

<b>Notice of References Cited</b>	Application/Control No. 10/669,289	Applicant(s)/Patent Under Reexamination MORINO, TAKASHI	
	Examiner Yubin Hung	Art Unit 2624	Page 1 of 1

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**NON-PATENT DOCUMENTS**

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	U	Marvel et al. ("Compression-Compatible Fragile and Semi-Fragile Tamper Detection," Proceedings of SPIE, Vol. 3971, 2000, pp. 131-139)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.